Unit in mm

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

2 S D 2 4 6 2

POWER AMPLIFIER APPLICATIONS.

• High DC Current Gain

: h_{FE (1)}=800~3200

• Low Collector Saturation Voltage

: $V_{CE (sat)} = 0.4V (Typ.)$

• Complementary to 2SB1602

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT	
Collector-Base Voltage		v_{CBO}	60	V	
Collector-Emitter Voltage		v_{CEO}	60	V	
Emitter-Base Voltage		$V_{ m EBO}$	7	V	
Collector Current	DC	$I_{\mathbf{C}}$	3	A	
	Pulse	I_{CP}	6		
Base Current		$I_{\mathbf{B}}$	0.6	A	
Collector Power Dissipation		$P_{\mathbf{C}}$	1.3	W	
Junction Temperature		T_{j}	150	$^{\circ}\mathrm{C}$	
Storage Temperature Range		$\mathrm{T_{stg}}$	-55~150	$^{\circ}\mathrm{C}$	

3.0±0.2 1.4±0.1 1.05±0.1 1.05±0.1 1.05±0.1 2.5±0.5 1. EMITTER 2. COLLECTOR 3. BASE

Weight: 0.55g (Typ.)

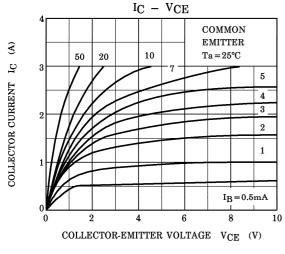
2-8M1A

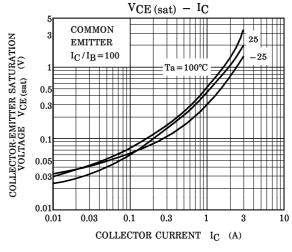
EIAJ TOSHIBA

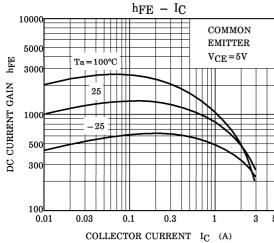
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

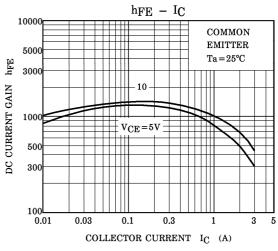
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	ICBO	$V_{CB} = 60V, I_{E} = 0$	_	_	100	μ A
Emitter Cut-off Current	IEBO	$V_{EB} = 7V, I_C = 0$	_		100	μ A
Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_{C} = 50 \text{mA}, I_{B} = 0$	60	_	_	V
DC Current Gain	h _{FE (1)}	$V_{CE} = 5V, I_{C} = 0.2A$	800	_	3200	
	h _{FE} (2)	$V_{CE} = 5V, I_{C} = 1.5A$	350	_	_	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$I_{C}=1A, I_{B}=10mA$	_	0.4	1.0	V
Base-Emitter Voltage	$ m V_{BE}$	$V_{CE} = 5V, I_{C} = 0.5A$	_	0.7	1.0	V
Transition Frequency	$ m f_{T}$	$V_{CE} = 5V, I_{C} = 0.5A$	_	18	_	MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1MHz$	_	42	_	pF

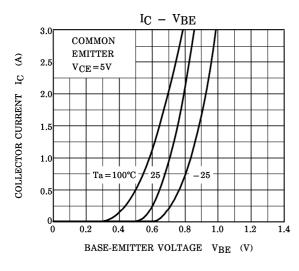
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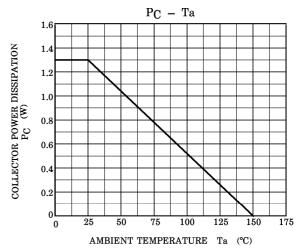




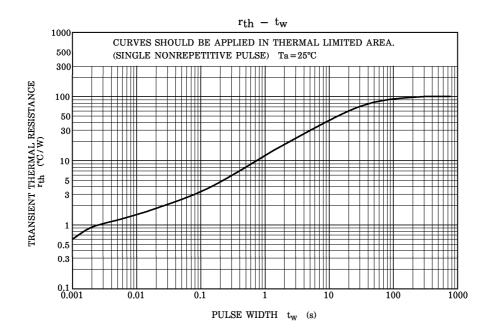


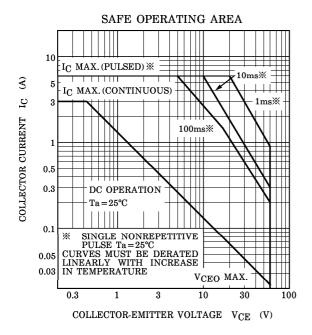






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